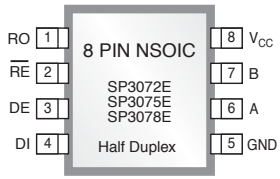
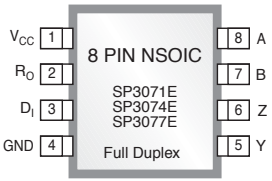
查询SP3070-3078E供应商

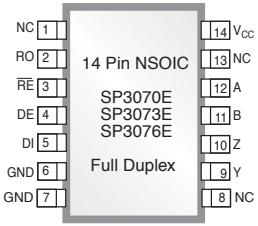
±15kV ESD-Protected, 3.3V, 1/8 Load, Failsafe RS-485/RS422 Transceivers

FEATURES

- ±15kV ESD protection for RS485 pins
- 3.3V low-power operation
- Advanced Receiver-failsafe protection for open, shorted or terminated lines
- Up to 256 Transceivers may share Bus
- Very low load for 8x greater fanout
- Hot Swap glitch protection $\overline{RE}$ and DE
- Thermal shutdown protects against driver contention
- Available in three industry standard foot-prints
  - SP3070E, 3073 and 3076 in Full-Duplex (14 pin)
  - SP3071E, 3074 and 3077 in Full-Duplex (8 pin)
  - SP3072E, 3075 and 3078 in Half-Duplex (8 pin)
- Three applications-optimized speed grades
  - SP3070-72E: 250kbps slew-limited
  - SP3073-75E: 500kbps slew-limited
  - SP3076-78E: 16Mbps high speed
- Small form factor SO-narrow packages
- Industrial (-40 to +85ºC) and Extended (-40 to +85ºC) temperature grades







Now Available in Lead Free Packaging

APPLICATIONS

- Industrial Control, Utility Meters Building Automation, Instrumentation, Point of Sale

DESCRIPTION

The SP3070-3078E differential line transceivers are suitable for bidirectional communication on balanced multipoint bus transmission lines and comply with both RS485 and RS422 EIA Standards. Each device consists of a differential driver and differential receiver. All devices operate from a 3.3V power supply.

High receiver input impedance allows a large number of transceivers to share a common data bus while maintaining signal margin and without excessive loading or use of expensive repeaters. The high impedance driver output is maintained over the entire common-mode voltage range from -7 to +12V. Receivers will failsafe to logic 1 output when inputs are open, shorted or terminated. Drivers include built-in short-circuit protection and a thermal-overload shutdown to protect against excessive power dissipation from bus contention or cable faults. All RS485 inputs are ESD protected up to ±15kV (Air-Gap and Human Body Model) and up to ±8kV Contact discharge (IEC 1000-4-2).

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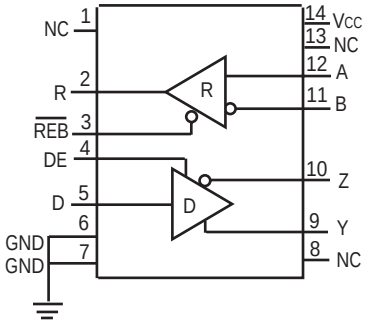
DEVICE ARCHITECTURE AND BLOCK DIAGRAMS

Devices are available in three industry standard architectures and footprints. In each footprint there are three speed grades available.

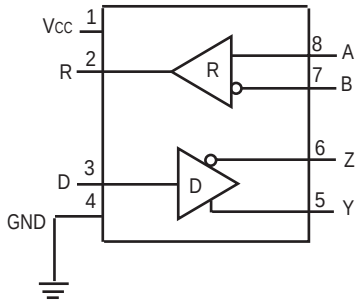


14 Pin Full Duplex:

SP3070E, 250kbps slew limited

SP3073E, 500kbps slew limited

SP3076E, 16Mbps

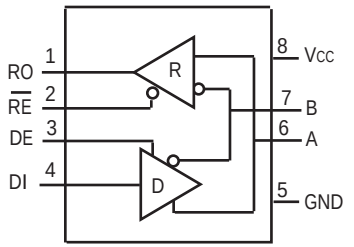


8 Pin Full Duplex:

SP3071E, 250kbps slew limited

SP3074E, 500kbps slew limited

SP3077E, 16Mbps



8 Pin Half Duplex:

SP3072E, 250kbps slew limited

SP3075E, 500kbps slew limited

SP3078E, 16Mbps

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ABSOLUTE MAXIMUM RATINGS

These are stress ratings only and functional operation of the device at these ratings or any other above those indicated in the operation sections of the specifications below is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

V_{CC} ..... +6.0V
Input Voltage at control input pins ($\overline{RE}$, DE) ..... -0.3V to 6V
Driver Input Voltage ($\overline{RE}$, DE) ..... -0.3V to 6V
Driver Output Voltage (A, B, Y, & Z) ..... -8V to +13V
Receiver Input Voltage (A, B) ..... -8V to +13V

Continuous Power Dissipation at Ta = 70°C
8-pin SO (derate 5.88mW/°C above +70°C) 471mW
8-pin PDIP (derate 9.29mW/°C above +70°C) 727mW
14-pin SO (derate 8.33mW/°C above +70°C) 667mW
14-pin PDIP (derate 10mW/°C above +70°C) 800mW
Operating Temperature Ranges
SP307_EMN ..... -40°C to +125°C
SP307_EEN ..... -40°C to +85°C
Junction Temperature ..... +150°C
Storage Temperature Range ..... -65°C to +150° C
Lead Temperature (soldering, 10s) ..... +300° C

ELECTRICAL CHARACTERISTICS

Unless otherwise noted V_{CC} = +3.3 ±0.3V, ambient temperature $T_{MIN} < T_A < T_{MAX}$. Typical values are at V_{CC} = 3.3, ambient temperature T_A = +25°C. The ♦ denotes the specifications which apply over the full operating range unless otherwise noted.

PARAMETER	SYM.	MIN.	TYP.	MAX.	UNITS	♦	CONDITIONS	
Differential Driver Output	V_{OD}	2		V_{CC}	V		RL = 100Ω (RS-422), Figure 1	
		1.5		V_{CC}			RL = 54Ω (RS-485), Figure 1	
				V_{CC}		♦	No Load	
Change in Magnitude of Differential Output Voltage	ΔV_{OD}			0.2	V	♦	RL = 54 or 100Ω , Figure 1	
Driver Common Mode Output Voltage	V_{OC}		$V_{CC}/2$	3	V	♦	RL = 54 or 100Ω , Figure 1	
Change in Magnitude of Common Mode Output Voltage	$\lvert\Delta V_{OC}\rvert$			±0.2	V		RL = 54 or 100Ω , Figure 1	
Input High Voltage	V_{IH}	2			V	♦	DE, DI, $\overline{RE}$	
Input Low Voltage	V_{IL}			0.8	V		DE, DI, $\overline{RE}$	
Input Hysteresis	V_{HYS}		100		mV	♦	DE, DI, $\overline{RE}$	
Input Current	I_{IN}	-1		1	µA	♦	DE, DI, $\overline{RE}$	
Input Impedance First Transition (Hotswap)		1		10	kΩ	♦	DE, $\overline{RE}$ First transition will draw more current (Hotswap)	
Output Leakage (Y and Z) Full Duplex (A and B)	I_O			+125	µA	♦	DE = GND V_{CC} = GND or 3.6V	V_{IN} = +12 V
		-100				♦		V_{IN} = -7V
Driver Short-Circuit Current	I_{OSD}	0		±250	mA		-7V ≤ V_{OUT} ≤ 12V, (Figure 4A)	
		-250		0				

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ELECTRICAL CHARACTERISTICS

Unless otherwise noted V_{CC} = +3.3 ±0.3V, ambient temperature $T_{MIN} < T_A < T_{MAX}$. Typical values are at V_{CC} = 3.3, ambient temperature T_A = +25ºC. The ♦ denotes the specifications which apply over the full operating range unless otherwise noted.

PARAMETERS	SYM	MIN	TYP	MAX	UNITS	♦	CONDITIONS	
Input Current (A and B) Half Duplex	$I_{A,B}$			125	µA	♦	DE = GND V_{CC} = GND or 3.6	V_{IN} = +12V
		-100						V_{IN} = -7V
Thermal-Shutdown Threshold	T_{TS}		165		ºC	♦		
Thermal Shutdown Hysteresis	T_{TSH}		15		ºC	♦		
RECEIVER								
Receiver Differential Threshold (Sensitivity)	V_{TH}	-200	-125	-50	mV		-7V≤ V_{CM} ≤ 12V	
Receiver Input Hysteresis	Δ V_{TH}		15		mV	♦	Va + Vb = 0V	
RO Output High Voltage	V_{OH}	Vcc - 0.6			V	♦	I_O = -1mA	
RO Output Low Voltage	V_{OL}			0.4	V	♦	I_O = 1mA	
Tri-State Output Current at Receiver	I_{OZR}			+/-1	µA	♦	0≤ V_O ≤ V_{CC}	
Receiver Input Resistance	R_{IN}	96			kΩ	♦	-7V ≤ V_{CM} ≤ 12V	
Receiver Output Short-Circuit Current	I_{OZR}			±60	mA		0V ≤ V_{RO} ≤ V_{CC}	
SUPPLY CURRENT								
Supply Current	I_{CC}		0.8	1.5	mA	♦	No Load, $\overline{RE}$ = 0, DE = V_{CC}	
			0.8	1.5			No Load, $\overline{RE}$ = V_{CC}, DE = V_{CC}	
			0.8	1.5			No Load, $\overline{RE}$ = 0, DE = 0	
Supply Current in Shutdown mode	I_{SHDN}		0.05	3	µA		$\overline{RE}$ = V_{CC}, DE = GND	
ESD PROTECTION								
ESD Protection for Y, Z, A, and B		±15			kV	♦	Human Body Model	
		±15					Air Gap (IEC 1000-4-2)	
		±8					Contact (IEC 1000-4-2)	

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DRIVER SWITCHING CHARACTERISTICS

Unless otherwise noted V_{CC} = +3.3 ±0.3V, ambient temperature $T_{MIN} < T_A < T_{MAX}$. Typical values are at V_{CC} = 3.3, ambient temperature T_A = +25ºC.

SP3070E, SP3071E & SP3072E DRIVER SWITCHING CHARACTERISTICS						
PARAMETER	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNITS**	**CONDITIONS**
Driver Propagation Delay	t_{DPLH}	250	-	1500	ns	C_L = 50pF, R_L = 54Ω, Figure 2 & 3
	t_{DPHL}	250	-	1500	ns	
Driver Differential Output Rise or Fall Time	$t_{DR,}$ t_{DF}	350	-	1600	ns	C_L = 50pF, R_L = 54Ω, Figure 2 & 3
Driver Differential Output Skew (t_{DPLH} - t_{DPHL})	t_{DSKEW}	-	-	200	ns	C_L = 50pF, R_L = 54Ω, Figure 2 & 3
Maximum Data Rate		250	-	-	kbps	
Driver Enable to Output High	t_{DZH}	-	-	2500	ns	Figure 4
Driver Enable to Output Low	t_{DZL}	-	-	2500	ns	Figure 5
Driver Disable Time from Low	t_{DLZ}	-	-	100	ns	Figure 5
Driver Disable Time from High	t_{DHZ}	-	-	100	ns	Figure 4
Driver Enable from Shutdown to Output High	$t_{DZH(SHDN)}$	-	-	5500	ns	Figure 4
Driver Enable from Shutdown to Output Low	$t_{DZL(SHDN)}$	-	-	5500	ns	Figure 5
Time to Shutdown	t_{SHDN}	50	200	600	ns	

RECEIVER SWITCHING CHARACTERISTICS

Unless otherwise noted V_{CC} = +3.3 ±0.3V, ambient temperature $T_{MIN} < T_A < T_{MAX}$. Typical values are at V_{CC} = 3.3, ambient temperature T_A = +25ºC.

Receiver Switching Characteristics SP3070, SP3071 & SP3072						
PARAMETER	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNITS**	**CONDITIONS**
Receiver Propagation Delay	t_{RPLH}	-	-	200	ns	C_L = 15pF, Figure 6 & 7
	t_{RPHL}	-	-	200	ns	
Receiver Output Skew (t_{DPLH} - t_{DPHL})	t_{RSKEW}	-	-	30	ns	C_L = 15pF, Figure 6 & 7
Data Rate		250	-	-	kbps	
Receiver Enable to Output High	t_{RZH}	-	-	50	ns	Figure 8
Receiver Enable to Output Low	t_{RZL}	-	-	50	ns	Figure 8
Receiver Disable Time from Low	t_{RLZ}	-	-	200	ns	Figure 8
Receiver Disable Time from High	t_{RHZ}	-	-	100	ns	Figure 8
Receiver Enable from Shutdown to Output High	$t_{RZH(SHDN)}$	-	-	4000	ns	Figure 8
Receiver Enable from Shutdown to Outtput Low	$t_{RZL(SHDN)}$	-	-	4000	ns	Figure 8

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DRIVER SWITCHING CHARACTERISTICS

Unless otherwise noted V_{CC} = +3.3 ±0.3V, ambient temperature $T_{MIN} < T_A < T_{MAX}$. Typical values are at V_{CC} = 3.3, ambient temperature T_A = +25ºC.

SP3073E, SP3074E & SP3075E DRIVER SWITCHING CHARACTERISTICS						
PARAMETER	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNITS**	**CONDITIONS**
Driver Propagation Delay	t_{DPLH}	180	-	800	ns	C_L = 50pF, R_L = 54Ω , Figure 2 & 3
	t_{DPHL}	180	-	800	ns	
Driver Differential Output Rise or Fall Time	$t_{DR,}$ t_{DF}	200	-	800	ns	C_L = 50pF, R_L = 54Ω , Figure 2 & 3
Driver Differential Output Skew (t_{DPLH} - t_{DPHL})	t_{DSKEW}	-	-	100	ns	C_L = 50pF, R_L = 54Ω , Figure 2 & 3
Data Rate		500	-	-	kbps	
Driver Enable to Output High	t_{DZH}	-	-	2500	ns	Figure 4
Driver Enable to Output Low	t_{DZL}	-	-	2500	ns	Figure 5
Driver Disable Time from Low	t_{DLZ}	-	-	100	ns	Figure 5
Driver Disable Time from High	t_{DHZ}	-	-	100	ns	Figure 4
Driver Enable from Shutdown to Output High	$t_{DZH(SHDN)}$	-	-	4500	ns	Figure 4
Driver Enable from Shutdown to Output Low	$t_{DZL(SHDN)}$	-	-	4500	ns	Figure 5
Time to Shutdown	t_{SHDN}	50	200	600	ns	

RECEIVER SWITCHING CHARACTERISTICS

Unless otherwise noted V_{CC} = +3.3 ±0.3V, ambient temperature $T_{MIN} < T_A < T_{MAX}$. Typical values are at V_{CC} = 3.3, ambient temperature T_A = +25ºC.

Receiver Switching Characteristics SP3073, SP3074 & SP3075						
PARAMETER	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNITS**	**CONDITIONS**
Receiver Propagation Delay	t_{RPLH}	-	-	200	ns	C_L = 15pF, Figure 6 & 7
	t_{RPHL}	-	-	200	ns	
Receiver Output Skew (t_{DPLH} - t_{DPHL})	t_{RSKEW}	-	-	30	ns	C_L = 15pF, Figure 6 & 7
Maximum Data Rate		500	-	-	kbps	
Receiver Enable to Output High	t_{RZH}	-	-	50	ns	Figure 8
Receiver Enable to Output Low	t_{RZL}	-	-	50	ns	Figure 8
Receiver Disable Time from Low	t_{RLZ}	-	-	50	ns	Figure 8
Receiver Disable Time from High	t_{RHZ}	-	-	50	ns	Figure 8
Receiver Enable from Shutdown to Output High	$t_{RZH(SHDN)}$	-	-	4000	ns	Figure 8
Receiver Enable from Shutdown to Outtput Low	$t_{RZL(SHDN)}$	-	-	4000	ns	Figure 8
Time to Shutdown	t_{SHDN}	50	200	600	ns	

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DRIVER SWITCHING CHARACTERISTICS

Unless otherwise noted Vcc=+3.3±0.3V, ambient temperature Tmin < Ta < Tmax. Typical values are at Vcc = 3.3, ambient temperature Ta = +25ºC

SP3076E, SP3077E & SP3078E DRIVER SWITCHING CHARACTERISTICS						
PARAMETER	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNITS**	**CONDITIONS**
Driver Propagation Delay	t_{DPLH}	-	-	50	ns	C_L = 50pF, R_L = 54Ω , Figure 2 & 3
	t_{DPHL}	-	-	50	ns	
Driver Differential Output Rise or Fall Time	$t_{DR,}$ t_{DF}	-	-	15	ns	C_L = 50pF, R_L = 54Ω , Figure 2 & 3
Driver Differential Output Skew (t_{DPLH} - t_{DPHL})	t_{DSKEW}	-	-	8	ns	C_L = 50pF, R_L = 54Ω , Figure 2 & 3
Data Rate		16	-	-	Mbps	
Driver Enable to Output High	t_{DZH}	-	-	150	ns	Figure 4
Driver Enable to Output Low	t_{DZL}	-	-	150	ns	Figure 5
Driver Disable Time from Low	t_{DLZ}	-	-	100	ns	Figure 5
Driver Disable Time from High	t_{DHZ}	-	-	100	ns	Figure 4
Driver Enable from Shutdown to Output High	$t_{DZH(SHDN)}$	-	-	1800	ns	Figure 4
Driver Enable from Shutdown to Output Low	$t_{DZL(SHDN)}$	-	-	1800	ns	Figure 5
Time to Shutdown	t_{SHDN}	50	200	600	ns	

RECEIVER SWITCHING CHARACTERISTICS

Unless otherwise noted Vcc=+3.3±0.3V, ambient temperature Tmin < Ta < Tmax. Typical values are at Vcc = 3.3, ambient temperature Ta = +25ºC

Receiver Switching Characteristics SP3076, SP3077 & SP3078						
PARAMETER	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNITS**	**CONDITIONS**
Receiver Propagation Delay	t_{RPLH}	-	40	75	ns	C_L = 15pF, Figure 6 & 7, -40 to +85ºC
	t_{RPHL}	-	40	75	ns	
Receiver Output Skew (t_{DPLH} - t_{DPHL})	t_{RSKEW}	-	-	8	ns	C_L = 15pF, Figure 6 & 7,
Data Rate		16	-	-	Mbps	
Receiver Enable to Output High	t_{RZH}	-	-	60	ns	Figure 8, -40 to +85ºC
Receiver Enable to Output Low	t_{RZL}	-	-	60	ns	Figure 8, -40 to +85ºC
Receiver Disable Time from Low	t_{RLZ}	-	-	50	ns	Figure 8
Receiver Disable Time from High	t_{RHZ}	-	-	50	ns	Figure 8
Receiver Enable from Shutdown to Output High	$t_{RZH(SHDN)}$	-	-	1800	ns	Figure 8
Receiver Enable from Shutdown to Output Low	$t_{RZL(SHDN)}$	-	-	1800	ns	Figure 8
Time to Shutdown	t_{SHDN}	50	200	600	ns	

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FIGURE 1. DRIVER DC TEST CIRCUIT

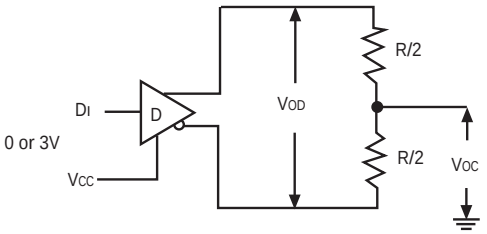


FIGURE 2. RECEIVER DC TEST CIRCUIT

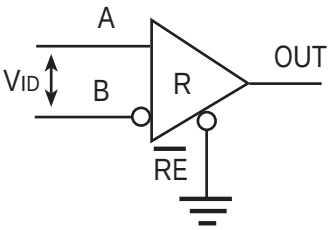
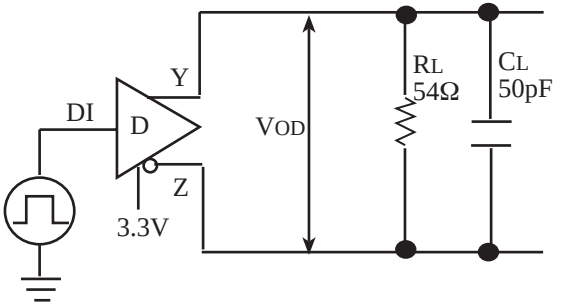


FIGURE 3. DRIVER PROPAGATION DELAY TIME TEST CIRCUIT AND TIMING DIAGRAM



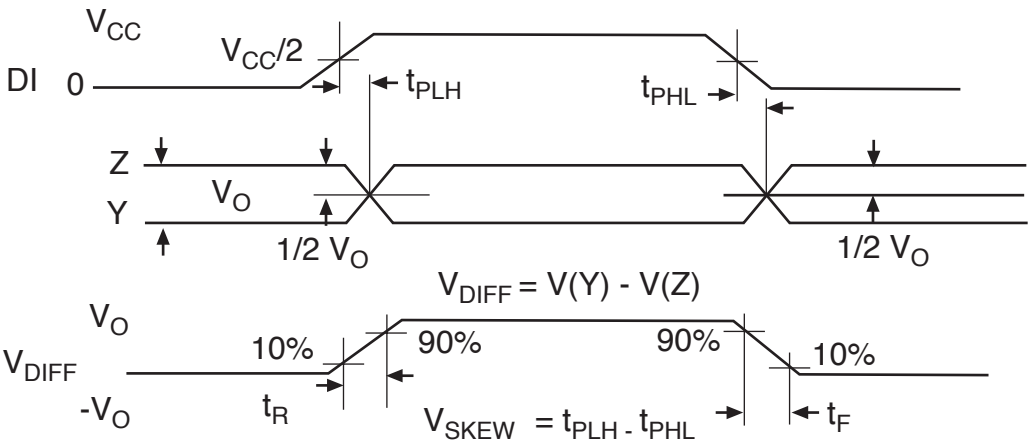


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FIGURE 4. DRIVER ENABLE & DISABLE TIMES TEST CIRCUIT & TIMING DIAGRAM

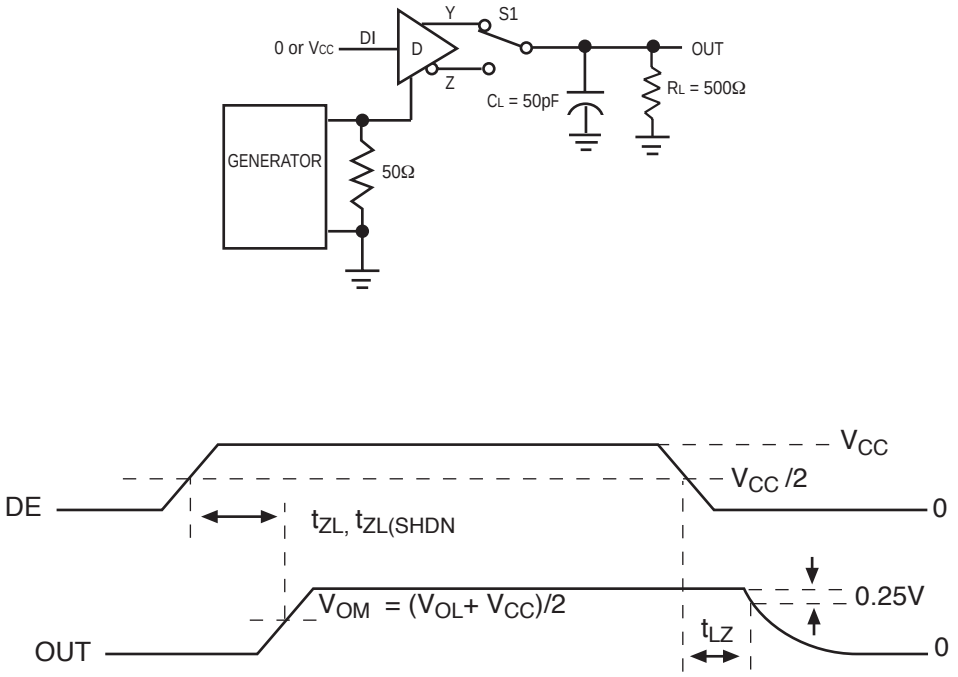

FIGURE 4A. DRIVER CONTENTION TEST

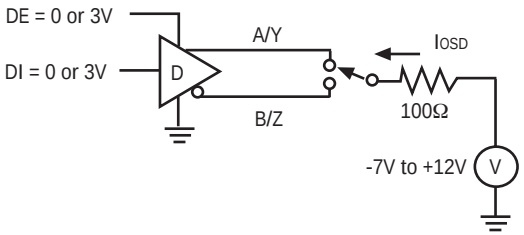

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FIGURE 5. DRIVER ENABLE & DISABLE TIMES TEST CIRCUIT & TIMING DIAGRAM

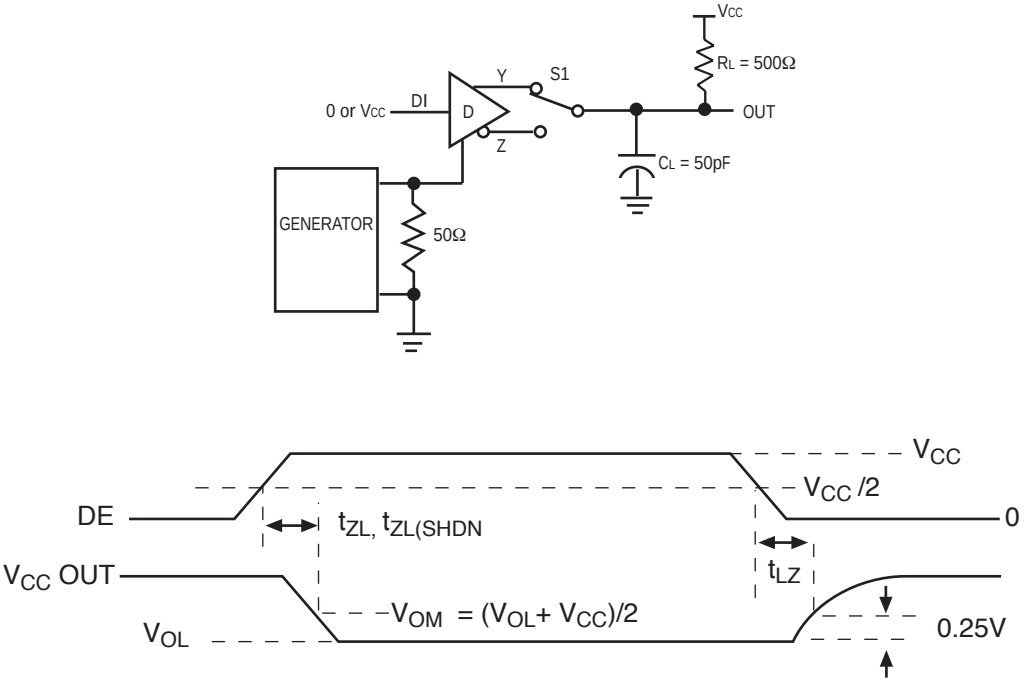

FIGURE 6. RECEIVER PROPAGATION DELAY TEST CIRCUIT & TIMING DIAGRAM

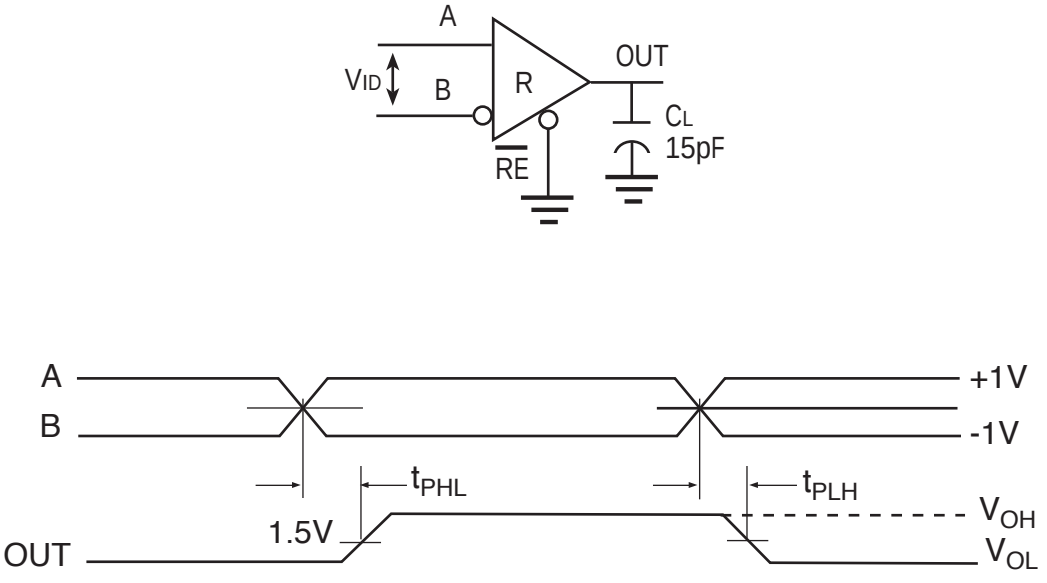

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FIGURE 7. RECEIVER ENABLE & DISABLE TIMES TEST CIRCUIT

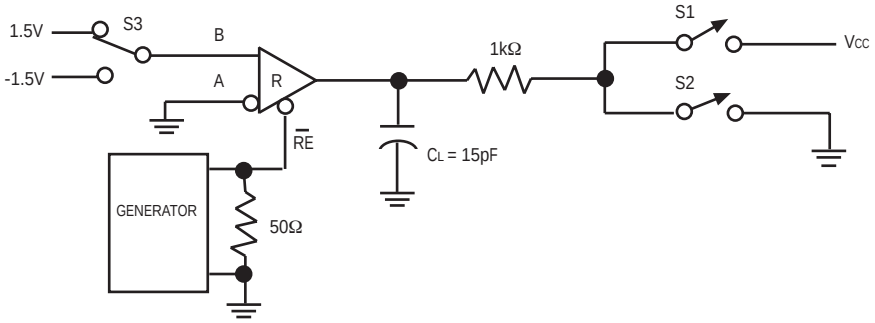
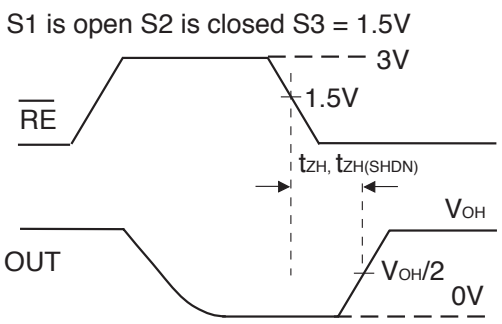
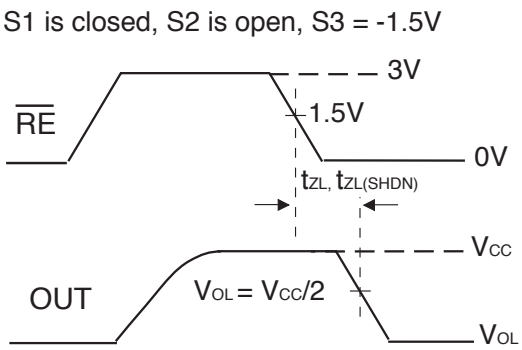
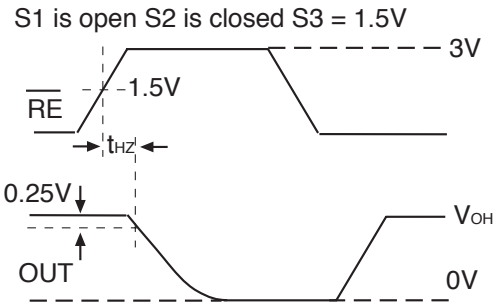
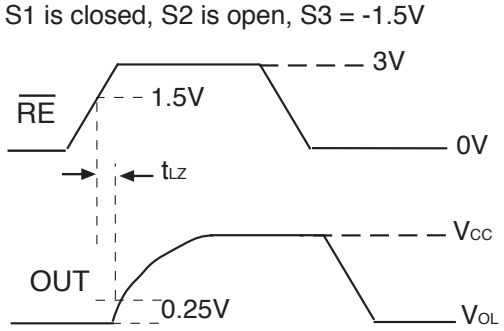


FIGURE 8. RECEIVER ENABLE & DISABLE TIMING DIAGRAM









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SP3070E, SP3073E, SP3076E (Full Duplex)				
TRANSMITTING				
Inputs			Outputs	
$\overline{RE}$	DE	DI	Z	Y
X	1	1	0	1
X	1	0	1	0
0	0	X	High-Z	
1	0	X	Shutdown	

SP3070E, SP3073E, SP3076E (Full Duplex)			
RECEIVING			
Inputs			Output
$\overline{RE}$	DE	A, B	RO
0	X	≥ -50mV	1
0	X	≤ -200mV	0
X	X	Open, Shorted	1
1	1	X	High-Z
1	0	X	Shutdown

SP3071E, SP3074E, SP3077E (Full Duplex)		
TRANSMITTING		
Inputs	Outputs	
DI	Z	Y
1	0	1
0	1	0

SP3071E, SP3074E, SP3077E (Full Duplex)	
RECEIVING	
Inputs	Output
A, B	RO
≥ -50mV	1
≤ -200mV	0
Open/shorted	1

SP3072E, SP3075E, SP3078E (Half Duplex)				
TRANSMITTING				
Inputs			Outputs	
$\overline{RE}$	DE	DI	B/Z	A/Y
X	1	1	0	1
X	1	0	1	0
0	0	X	High-Z	
1	0	X	Shutdown	

SP3072E, SP3075E, SP3078E (Half Duplex)			
RECEIVING			
Inputs			Output
$\overline{RE}$	DE	A, B	RO
0	X	≥ -50mV	1
0	X	≤ -200mV	0
X	X	Open/shorted	1
1	1	X	High-Z
1	0	X	Shutdown

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FULL DUPLEX DEVICES		HALF DUPLEX DEVICES	PIN NAME	PIN FUNCTION
SP3070E	SP3071E	SP3072E		
SP3073E	SP3074E	SP3075E		
SP3076E	SP3077E	SP3078E		
PIN NUMBER				
2	2	1	RO	Receiver Output. When $\overline{RE}$ is low and if (A – B) ≥ -50mV, RO is High. If (A – B) ≤ - 200mV, RO is low.
3	-	2	$\overline{RE}$	Receiver Output Enable. When $\overline{RE}$ is low, RO is enabled. When $\overline{RE}$ is high, RO is high impedance. $\overline{RE}$ should be high and DE low to enter shutdown mode. $\overline{RE}$ is a hot-swap input.
4	-	3	DE	Driver Output Enable. When DE is high, outputs are enabled. When DE is low, outputs are high impedance. DE should be low and $\overline{RE}$ high to enter shutdown mode. DE is a hot-swap input.
5	3	4	DI	Driver Input. With DE high, a low level on DI forces noninverting output low and inverting output high. Similarly, a high level on DI forces noninverting output high and inverting output low.
6, 7	4	5	GND	Ground
9	5	-	Y	Noninverting Driver Output
10	6	-	Z	Inverting Driver Output
11	7	-	B	Inverting Receiver Input
-	-	7	B	Inverting Receiver Input and Inverting Driver Output
12	8	-	A	Noninverting Receiver Input
-	-	6	A	Noninverting Receiver Input and Noninverting Driver Output
14	1	8	V_{CC}	Positive Supply V_{CC}. Bypass V_{CC} to GND with a 0.1uF capacitor.
1, 8, 13	-	-	NC	No Connect

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DETAILED DESCRIPTION

The SP307XE family of high speed transceivers for RS-485/RS-422 communication contain one driver and one receiver. These devices feature fail-safe circuitry, which guarantees a logic-high receiver output when the receiver inputs are open or shorted, or when they are connected to a terminated transmission line with all drivers disabled. The SP3070E, SP3072E, SP3073E, SP3075E, SP3076E and SP3078E also feature a hotswap capability allowing live insertion without error data transfer. The SP3070E, SP3071E and SP3072E feature reduced slew-rate drivers that minimize EMI and reduce reflections caused by improperly terminated cables, allowing error-free data transmission up to 250kbps. The SP3073E, SP3074E and SP3075E also offer slew -rate limits allowing transmit speeds up to 500kbps. The SP3076E, SP3077E, SP3078E driver slew rates are not limited, making transmit speeds up to 16Mbps possible.

The SP3072E, SP3075E and SP3078E are half-duplex transceivers, while the SP3070E, SP3071E, SP3073E, SP3074E, SP3076E, and SP3077E are full duplex transceivers.

All devices operate from a single 3.3V supply. Drivers are output short-circuit current limited. Thermal-shutdown circuitry protects drivers against excessive power dissipation. When activated, the thermal-shutdown circuitry places the driver outputs into a high-impedance state.

RECEIVER INPUT FILTERING

SP3070-SP3075 receivers incorporate input filtering in addition to input hysteresis. This filtering enhances noise immunity with differential signals that have very slow rise and fall times. Receiver propagation delay increases by 25% due to this filtering.

FAIL SAFE

The SP3070 family guarantees a logic-high receiver output when the receiver inputs are shorted, open, or when they are connected to a terminated transmission line with all drivers disabled. If A - B is less than or equal to -200mV, RO is logic low. In the case of a terminated bus with all transmitters disabled the receiver's differential input voltage is pulled to 0V by the termination. With the receiver thresholds of the SP3070E family, this results in a logic high with a 50mV minimum noise margin. In compliance with the EIA/TIA-485 standard, the SP3070E family has a 50mV - 200mV threshold.

HOT-SWAP CAPABILITY

When circuit boards are inserted into a hot backplane, differential disturbances to the data bus can lead to data errors. Upon initial circuit board insertion, the data communication processor undergoes its own power-up sequence. During this period, the processor's logic-output drivers are high impedance and are unable to drive the DE and $\overline{RE}$ inputs of these devices to a defined logic level. Leakage currents up to 10μA from the high-impedance state of the processor's logic drivers could cause standard CMOS enable inputs of a transceiver to drift to an incorrect logic level. Additionally, parasitic circuit board capacitance could cause coupling of VCC or GND to the enable inputs. Without the hot-swap capability, these factors could improperly enable the transceiver's driver or receiver.

When VCC rises, an internal pulldown circuit holds DE low and $\overline{RE}$ high for approximately 10 microseconds. After the initial power-up sequence, the pulldown circuit becomes transparent, resetting the hot-swap tolerable input.

15KV ESD PROTECTION

As with all Sipex devices, ESD-protection structures are incorporated on all pins to protect against electrostatic discharges encountered during handling and assembly. The driver output and receiver inputs of the SP3070E family of devices have extra protection against static electricity. Sipex's engineering team have developed state of the art structures to protect these pins against ESD of 15kV without damage. The ESD structures withstand high ESD in all states: normal op-

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eration, shutdown, and powered down. After an ESD event, the SP3070E - SP3078E keep working without latchup or damage.

ESD protection can be tested in various ways. The transmitter outputs and receiver inputs of the SP3070E - SP3078E are characterized for protection to the following limits:

- ±15kV using the Human Body Model
- ±8kV using the Contact Discharge method specified in IEC 1000-4-2
- ±15kV Airgap

ESD TEST CONDITIONS

ESD performance depends on a variety of conditions. Contact Sipex for a reliability report that documents test setup, methodology and results.

IEC 1000-4-2

The IEC 1000-4-2 standard covers ESD testing and performance of finished equipment. However, it does not specifically refer to integrated circuits. The SP3070E family of devices helps you design equipment to meet IEC 1000-4-2, without the need for additional ESD-protection components.

The major difference between tests done using the Human Body Model and IEC 1000-4-2 is higher peak current in IEC 1000-4-2, because series resistance is lower in the IEC 1000-4-2 model. Hence, the ESD withstand voltage measured to EC 1000-4-2 is generally lower than that measured using the human body model.

The air-gap test involves approaching the device with a charged probe. The contact-discharge method connects the probe to the device before the probe is energized.

MACHINE MODEL

The machine model for ESD tests all pins using a 200pF storage capacitor and zero discharge resistance. The objective is to emulate the stress caused when I/O pins are contacted by handling equipment during test and assembly.

256 TRANSCEIVERS ON THE BUS

The standard RS-485 receiver input impedance is 12kΩ (1 unit load), and the standard driver can drive up to 32 unit loads. The SP3070E family of transceivers has a 1/8-unit load receiver input impedance (96Ω), allowing up to 256 transceivers to be connected in parallel on one communication line. Any combination of these devices as well as other RS-485 transceivers with a total of 32 unit loads or fewer can be connected to the line.

REDUCED EMI AND REFLECTIONS

The SP3070E, SP3071E and SP3072E feature reduced slew-rate drivers that minimize EMI and reduce reflections caused by improperly terminated cables, allowing error-free data transmission up to 250kbps. The SP3073, SP3074 and SP3075 offer higher driver output slew-rate limits, allowing transmit speeds up to 500kbps.

LOW POWER SHUTDOWN MODE

Low-power shutdown mode is initiated by bringing both $\overline{RE}$ high and DE low. In shutdown, the devices typically draw only 50nA of supply current.

$\overline{RE}$ and DE can be driven simultaneously; the parts are guaranteed not to enter shutdown if $\overline{RE}$ is high and DE is low for less than 50ns. If the inputs are in this state for at least 600ns, the parts are guaranteed to enter shutdown.

Enable times t_{ZH} and t_{ZL} assume the part was not in a low-power shutdown state. Enable times $t_{ZH(SHDN)}$ and $t_{ZL(SHDN)}$ assume the parts were shut down. It takes drivers and receivers longer to become enabled from low-power shutdown mode $t_{ZH(SHDN)}$ and $t_{ZL(SHDN)}$ than from driver/receiver-disable mode (t_{ZH}, t_{ZL})

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DRIVER OUTPUT PROTECTION

Two mechanisms prevent excessive output current and power dissipation caused by faults or by bus contention. First, current limit on the ouput stage, provides immediate protection against short circuits over the whole common-mode voltage range. Second, a thermal-shutdown circuit, forces the driver outputs into a high-impedance state if the die temperature becomes excessive.

LINE LENGTH

The RS-485/RS422 standard covers line lengths up to 4000ft.

TYPICAL APPLICATIONS

The SP3072E, SP3075E and SP3078E transceivers are designed for bidirectional data communications on multipoint bus transmission lines.

To minimize reflections, terminate the line at both ends in its characteristic impedance, and keep stub lengths off the main line as short as possible. The slew-rate-limited SP3070 - SP3075E are more tolerant of imperfect termination.

PARTS SELECTOR GUIDE

PART NUMBER	Half/Full Duplex	Datarate Mbps	Shut-down	Receiver Driver Enable	Trans. On Bus	Pin Count	Industry Standard Pinout	Pin Compatible Upgrade from:
SP3070E	Full	0.25	Yes	Yes	256	14	MAX3070E, 75180	
SP3071E	Full	0.25	No	No	256	8	MAX 3071E, 75179	SP3493
SP3072E	Half	0.25	Yes	Yes	256	8	MAX 3072E, 75176	SP3483
SP3073E	Full	0.5	Yes	Yes	256	14	MAX 3073E, 75180	
SP3074E	Full	0.5	No	No	256	8	MAX 3074E, 75179	
SP3075E	Half	0.5	Yes	Yes	256	8	MAX 3075E, 75176	SP3494
SP3076E	Full	16	Yes	Yes	256	14	MAX 3076E, 75180	SP3491
SP3077E	Full	16	No	No	256	8	MAX3077E, 75179	SP3490
SP3078E	Half	16	Yes	Yes	256	8	MAX 3078E, 75176	SP3485, SP3481

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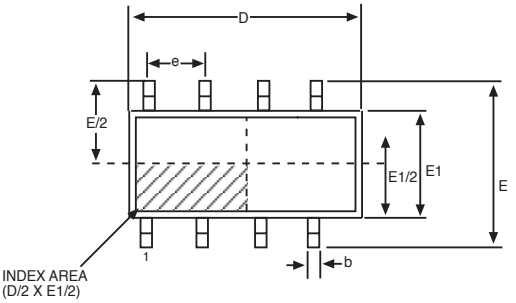
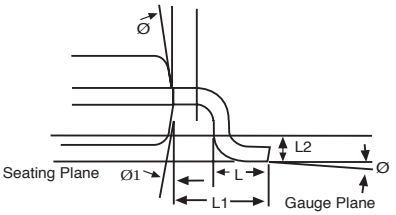
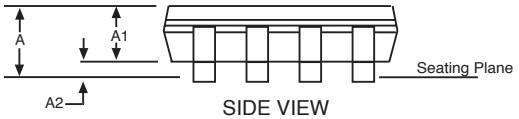


TOP VIEW



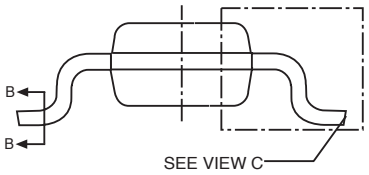
VIEW C

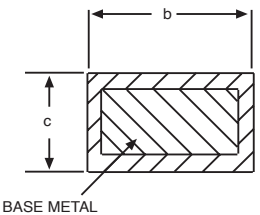


SIDE VIEW

8 Pin NSOIC JEDEC MO-012 (AA) Variation			
SYMBOL	MIN	NOM	MAX
A	1.35	-	1.75
A1	0.1	-	0.25
A2	1.25	-	1.65
b	0.31	-	0.51
c	0.17	-	0.24
D		4.90 BSC	
E		6.00 BSC	
E1		3.90 BSC	
e		1.27 BSC	
L	0.4	-	1.27
L1		1.04 REF	
L2		0.25 BSC	
ø	0º	-	8º
ø1	5º	-	15º

Note: Dimensions in (mm)





SECTION B-B
WITH PLATING

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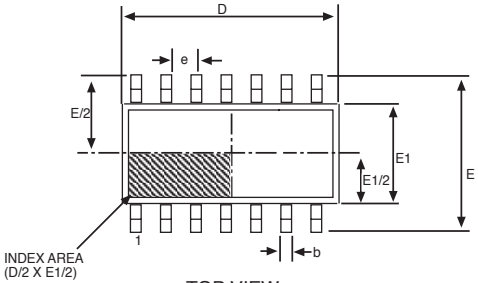
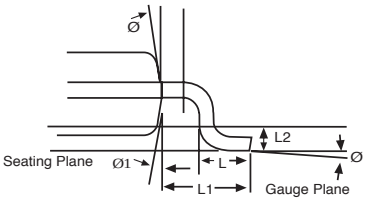
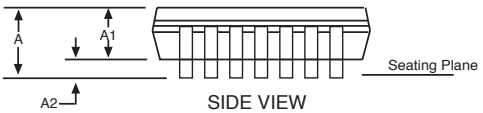


TOP VIEW



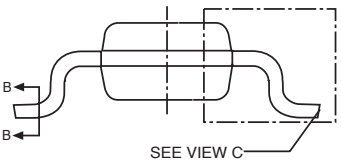
VIEW C

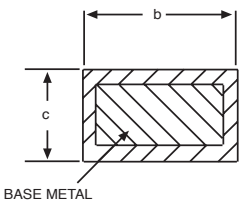


SIDE VIEW

14 Pin NSOIC JEDEC MO-012 (AB) Variation			
SYMBOL	MIN	NOM	MAX
A	1.35	-	1.75
A1	0.1	-	0.25
A2	1.25	-	1.65
b	0.31	-	0.51
c	0.17	-	0.25
D		8.65 BSC	
E		6.00 BSC	
E1		3.90 BSC	
e		1.27 BSC	
L	0.4	-	1.27
L1		1.04 REF	
L2		0.25 BSC	
ø	0º	-	8º
ø1	5º	-	15º

Note: Dimensions in (mm)





SECTION B-B
WITH PLATING

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ORDERING INFORMATION

Model	Temperature Range	Package
SP3070EEN	-40˚C to +85˚C	14-pin NSOIC
SP3070EEN/TR	-40˚C to +85˚C	14-pin NSOIC
SP3070EMN	-40˚C to +125˚C	14-pin NSOIC
SP3070EMN/TR	-40˚C to +125˚C	14-pin NSOIC
SP3071EEN	-40˚C to +85˚C	8-pin NSOIC
SP3071EEN/TR	-40˚C to +85˚C	8-pin NSOIC
SP3071EMN	-40˚C to +125˚C	8-pin NSOIC
SP3071EMN/TR	-40˚C to +125˚C	8-pin NSOIC
SP3072EEN	-40˚C to +85˚C	8-pin NSOIC
SP3072EEN/TR	-40˚C to +85˚C	8-pin NSOIC
SP3072EMN	-40˚C to +125˚C	8-pin NSOIC
SP3072EMN/TR	-40˚C to +125˚C	8-pin NSOIC
SP3073EEN	-40˚C to +85˚C	14-pin NSOIC
SP3073EEN/TR	-40˚C to +85˚C	14-pin NSOIC
SP3073EMN	-40˚C to +125˚C	14-pin NSOIC
SP3073EMN/TR	-40˚C to +125˚C	14-pin NSOIC
SP3074EEN	-40˚C to +85˚C	8-pin NSOIC
SP3074EEN/TR	-40˚C to +85˚C	8-pin NSOIC
SP3074EMN	-40˚C to +125˚C	8-pin NSOIC
SP3074EMN/TR	-40˚C to +125˚C	8-pin NSOIC
SP3075EEN	-40˚C to +85˚C	8-pin NSOIC
SP3075EEN/TR	-40˚C to +85˚C	8-pin NSOIC
SP3075EMN	-40˚C to +125˚C	8-pin NSOIC
SP3075EMN/TR	-40˚C to +125˚C	8-pin NSOIC
SP3076EEN	-40˚C to +85˚C	14-pin NSOIC
SP3076EEN/TR	-40˚C to +85˚C	14-pin NSOIC
SP3076EMN	-40˚C to +125˚C	14-pin NSOIC
SP3076EMN/TR	-40˚C to +125˚C	14-pin NSOIC
SP3077EEN	-40˚C to +85˚C	8-pin NSOIC
SP3077EEN/TR	-40˚C to +85˚C	8-pin NSOIC
SP3077EMN	-40˚C to +125˚C	8-pin NSOIC
SP3077EMN/TR	-40˚C to +125˚C	8-pin NSOIC
SP3078EEN	-40˚C to +85˚C	8-pin NSOIC
SP3078EEN/TR	-40˚C to +85˚C	8-pin NSOIC
SP3078EMN	-40˚C to +125˚C	8-pin NSOIC
SP3078EMN/TR	-40˚C to +125˚C	8-pin NSOIC

For availability of PDIP or other packaging contact factory.

Available in lead free packaging. To order add “-L” suffix to part number.

Example: SP3074EEN/TR = standard; SP3074EEN-L/TR = lead free

/TR = Tape and Reel

Pack quantity is 2,500 for NSOIC.

CLICK HERE TO ORDER SAMPLES

Sipex Corporation

ANALOG EXCELLENCE

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